International TOR Rectifier

AUTOMOTIVE GRADE

Features

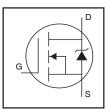
- Logic Level
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low onresistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

AUIRLR3705Z

HEXFET® Power MOSFET



V _{(BR)DSS}	55V
R _{DS(on)} max.	$\mathbf{8.0m}\Omega$
I _{D (Silicon Limited)}	89A
D (Package Limited)	42A



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	89	
I _D @ T _C = 100°C	Continuous Drain Current, VGS @ 10V (Silicon Limited)	63	А
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	42	
I _{DM}	Pulsed Drain Current ①	360	1
P _D @T _C = 25°C	Power Dissipation	130	W
	Linear Derating Factor	0.88	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 2	110	mJ
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ®	190	1
I _{AR}	Avalanche Current ①	See Fig.12a, 12b, 15, 16	Α
E _{AR}	Repetitive Avalanche Energy ®	-	mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	1

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		1.14	
$R_{\theta JA}$	Junction-to-Ambient (PCB mount) ^⑦		40	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.053		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		6.5	8.0	mΩ	V _{GS} = 10V, I _D = 42A ③
				11		$V_{GS} = 5.0V, I_D = 34A$ ③
				12		V _{GS} = 4.5V, I _D = 21A ③
$V_{GS(th)}$	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Transconductance	89			S	$V_{DS} = 25V, I_{D} = 42A$
I _{DSS}	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 55V, V_{GS} = 0V$
				250		$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	nA	V _{GS} = 16V
	Gate-to-Source Reverse Leakage			-200		V _{GS} = -16V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
_		IVIIII.		_	Units	
Q_g	Total Gate Charge		44	66		$I_D = 42A$
Q_{gs}	Gate-to-Source Charge		13		nC	$V_{DS} = 44V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		22			V _{GS} = 5.0V ③
t _{d(on)}	Turn-On Delay Time		17			$V_{DD} = 28V$
t _r	Rise Time		150			$I_D = 42A$
t _{d(off)}	Turn-Off Delay Time		33		ns	$R_G = 4.2 \Omega$
t _f	Fall Time		70	_	1	V _{GS} = 5.0V ③
L _D	Internal Drain Inductance		4.5			Between lead,
					nH	6mm (0.25in.)
L _S	Internal Source Inductance	T	7.5	_	1	from package
						and center of die contact
C _{iss}	Input Capacitance		2900			$V_{GS} = 0V$
C _{oss}	Output Capacitance		420	_	1	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		230	_	рF	f = 1.0MHz
C _{oss}	Output Capacitance	T	1550	_	1	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C _{oss}	Output Capacitance	T	320	_	1	$V_{GS} = 0V, V_{DS} = 44V, f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance	T	500		1	$V_{GS} = 0V$, $V_{DS} = 0V$ to 44V $\textcircled{4}$

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			42		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current		_	360		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage		_	1.3	V	$T_J = 25$ °C, $I_S = 42A$, $V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		21	42	ns	$T_J = 25^{\circ}C, I_F = 42A, V_{DD} = 28V$
Q _{rr}	Reverse Recovery Charge		14	28	nC	di/dt = 100A/µs ③
t _{on}	Forward Turn-On Time	Intrinsio	turn-or	time is	negligib	le (turn-on is dominated by LS+LD)

Notes:

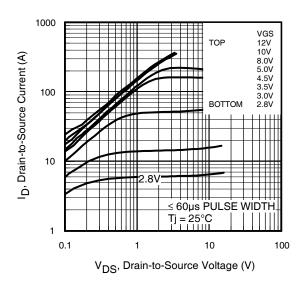
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 0.12mH $R_G = 25\Omega$, $I_{AS} = 42A$, $V_{GS} = 10V$. Part not recommended for use above this value.
- $\ \, \mbox{$ \oplus$ } \, C_{oss}$ eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- $\$ Limited by T_{Jmax} , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ® This value determined from sample failure population, starting $T_J = 25$ °C, L = 0.12mH, $R_G = 25\Omega$, $I_{AS} = 42$ A, $V_{GS} = 10$ V.
- ② When mounted on 1" square PCB (FR-4 or G-10 Material) . For recommended footprint and soldering techniques refer to application note #AN-994.
- $\ \ \, \mathbb{8} \ \, \mathsf{R}_{\theta} \hspace{0.5mm} \text{is measured at T}_{\mathsf{J}} \hspace{0.5mm} \text{approximately } 90^{\circ} \mathsf{C}.$

Qualification Information[†]

		Automotive			
		(per AEC-Q101) ^{††}			
Qualifica	tion Level	Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity Level		D-PAK	MSL1		
	Machine Model		Class M4 (425V)		
		AEC-Q101-002			
	Human Body Model		Class H1C (2000V)		
ESD			AEC-Q101-001		
	Charged Device	Class C5 (1125V)			
	Model	AEC-Q101-005			
RoHS Co	ompliant	Yes			

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

^{††} Exceptions to AEC-Q101 requirements are noted in the qualification report.



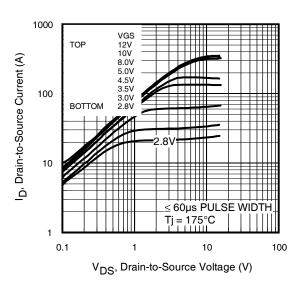
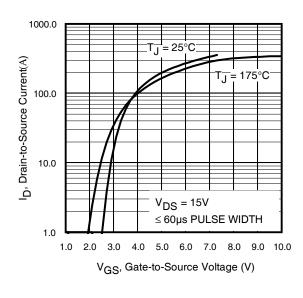


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



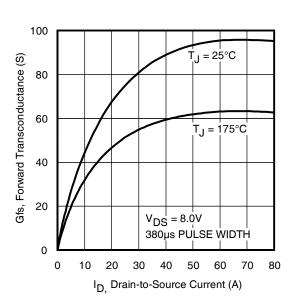
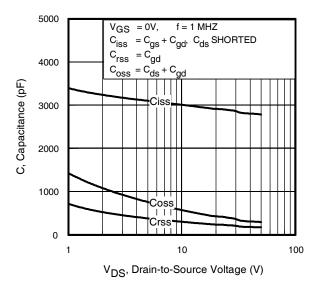


Fig 3. Typical Transfer Characteristics

Fig 4. Typical Forward Transconductance vs. Drain Current



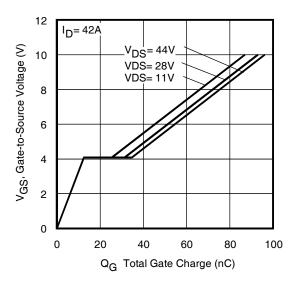
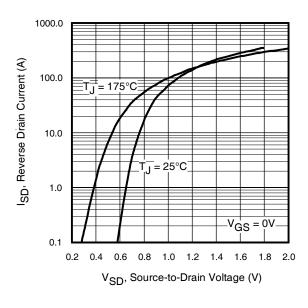


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



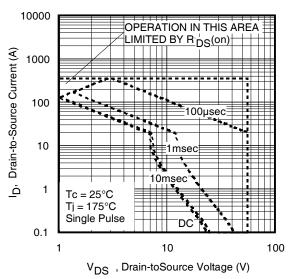


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

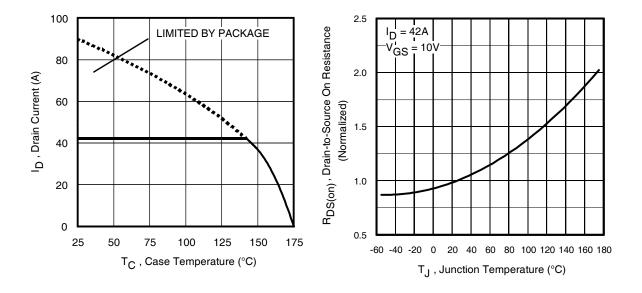


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

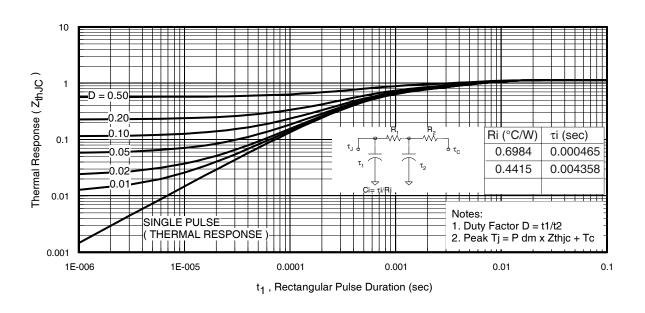


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

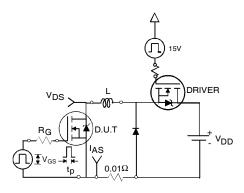


Fig 12a. Unclamped Inductive Test Circuit

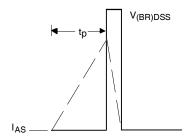


Fig 12b. Unclamped Inductive Waveforms

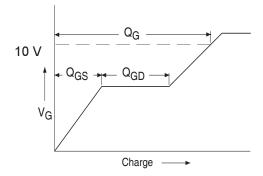
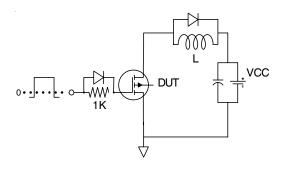


Fig 13a. Basic Gate Charge Waveform



500 $\mathsf{E}_{\mathsf{AS}_{,}}$ Single Pulse Avalanche Energy (mJ) I D 5.3A 7.0A TOP 400 BOTTOM 42A 300 200 100 0 25 50 150 75 100 125 175 Starting T_J, Junction Temperature (°C)

Fig 12c. Maximum Avalanche Energy vs. Drain Current

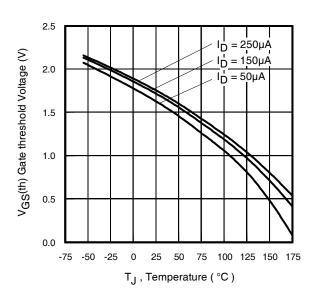


Fig 14. Threshold Voltage vs. Temperature

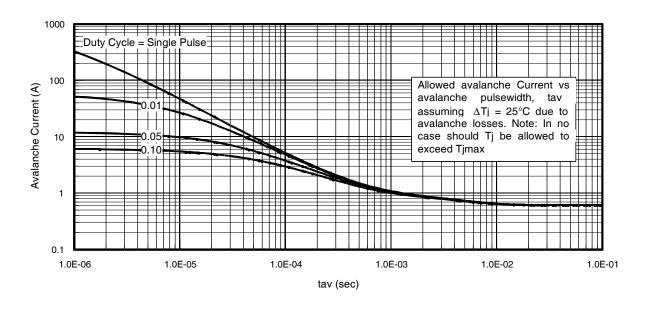
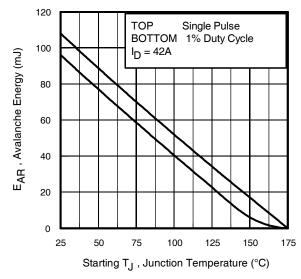


Fig 15. Typical Avalanche Current vs. Pulsewidth



Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:

 Purely a thermal phenomenon and failure
 - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long $\mbox{asT}_{\mbox{\scriptsize jmax}}$ is not exceeded.
- Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).
 - t_{av} = Average time in avalanche.
 - D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot \text{I}_{aV} \text{)} = \triangle \text{T/ } Z_{thJC} \\ I_{av} &= 2\triangle \text{T/ [} 1.3 \cdot \text{BV} \cdot Z_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

Fig 16. Maximum Avalanche Energy vs. Temperature

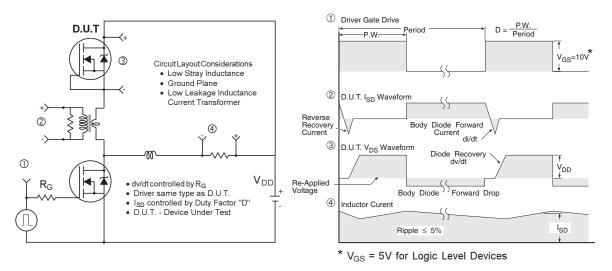


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

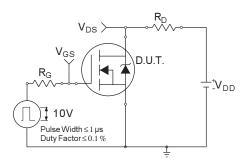


Fig 18a. Switching Time Test Circuit

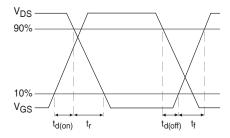
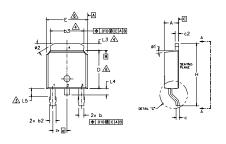
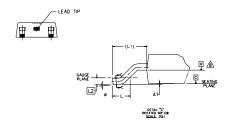


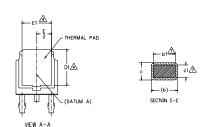
Fig 18b. Switching Time Waveforms

D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)







- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS]
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.

 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10

 [0.13 AND 0.25] FROM THE LEAD TIP.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY. A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA,

S		DIMEN		NO		
M B O	MILLIM	ETERS	INC	INCHES		
Ľ	MIN,	MAX.	MIN.	MAX.	Ė	
Α	2.18	2.39	.086	.094		
A1	-	0,13	-	.005		
ь	0.64	0.89	.025	.035		
ь1	0.65	0.79	.025	.031	7	
ь2	0,76	1,14	.030	.045		
b3	4.95	5.46	.195	.215	4	
c	0.46	0.61	.018	.024		
c1	0.41	0.56	.016	.022	7	
¢2	0.46	0.89	.018	.035		
D	5.97	5.22	.235	.245	6	L
D1	5.21	-	.205	-	4	
E	6.35	6.73	.250	.265	6	
E1	4.32	-	.170	-	4	L
e	2.29	BSC	.090	BSC	1	1
н	9.40	10.41	.370	.410		2 3
L	1,40	1,78	.055	.070		3
L1	2.74	BSC	.108	REF.		"
L2	0,51	BSC	.020	BSC		
L3	0.89	1.27	.035	.050	4	١.,
L4	-	1.02	-	.040		15
L5	1,14	1,52	.045	.060	3	1
ø	0*	10*	0.	10*		2 3
ø1	0*	15*	0,	15*		
ø2	25*	35*	25*	35*		4
	•					

LEAD ASSIGNMENTS

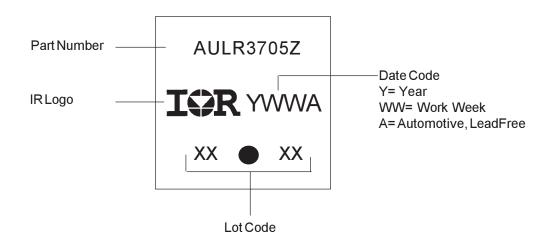
HEXFET

- 1,- GATE 2,- DRAIN 3,- SOURCE 4,- DRAIN

IGBT & CoPAK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

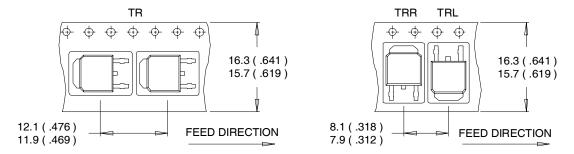
D-Pak Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

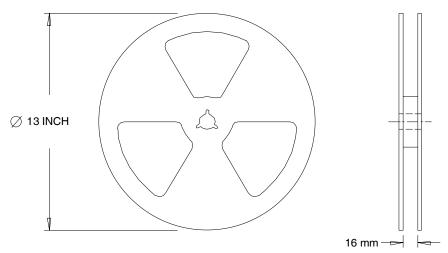
D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Ordering Information

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRLR3705Z	Dpak	Tube	75	AUIRLR3705Z
		Tape and Reel	2000	AUIRLR3705ZTR
		Tape and Reel Left	3000	AUIRLR3705ZTRL
		Tape and Reel Right	3000	AUIRLR3705ZTRR

AUIRLR3705Z

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